## FAIRCHILD

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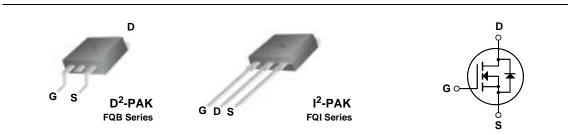
# **FQB55N10 / FQI55N10** N-Channel QFET MOSFET 100 V, 55 A, 26 mΩ

### Description

This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor®'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, DC motor control, and variable switching power applications.

### **Features**

- + 55 A, 100 V,  $R_{DS(on)}$  = 26 m $\Omega$  (Max) @V\_{GS} = 10 V,  $I_D$  = 27.5 A
- Low Gate Charge (Typ. 75 nC)
- Low Crss (Typ. 130 pF)
- 100% Avalanche Tested
- 175°C Maximum Junction Temperature Rating



### Absolute Maximum Ratings T<sub>c</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQB55N10 / FQI55N10	Unit
V <sub>DSS</sub>	Drain-Source Voltage		100	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C)		55	Α
	- Continuous (T <sub>C</sub> = 100°C)		38.9	Α
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	220	Α
V <sub>GSS</sub>	Gate-Source Voltage		± 25	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	1100	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	55	Α
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	15.5	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	6.0	V/ns
P <sub>D</sub>	Power Dissipation $(T_A = 25^{\circ}C)^{*}$		3.75	W
-	Power Dissipation ( $T_C = 25^{\circ}C$ )		155	W
	- Derate above 25°C		1.03	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +175	°C
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

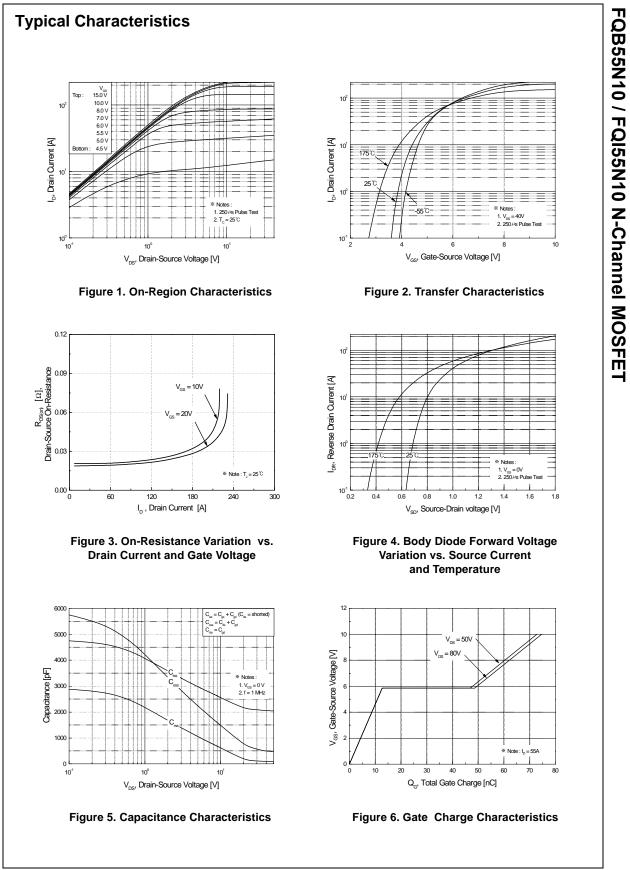
### **Thermal Characteristics**

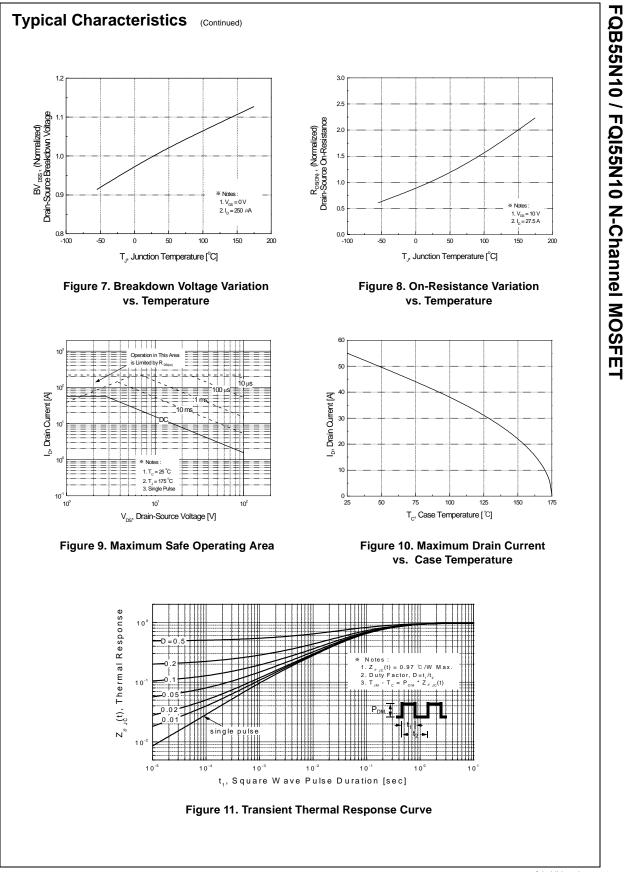
Symbol	Parameter	Тур	Max	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.97	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

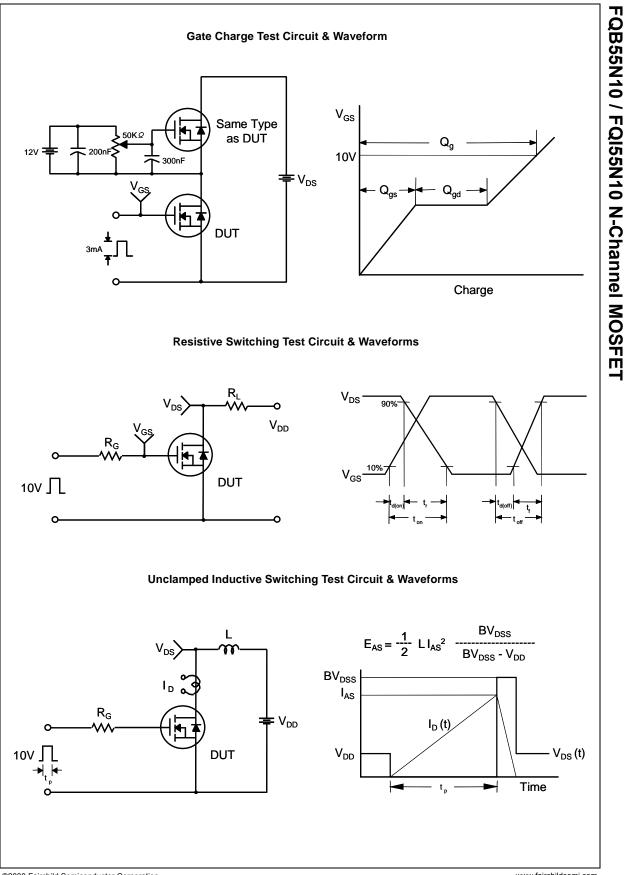
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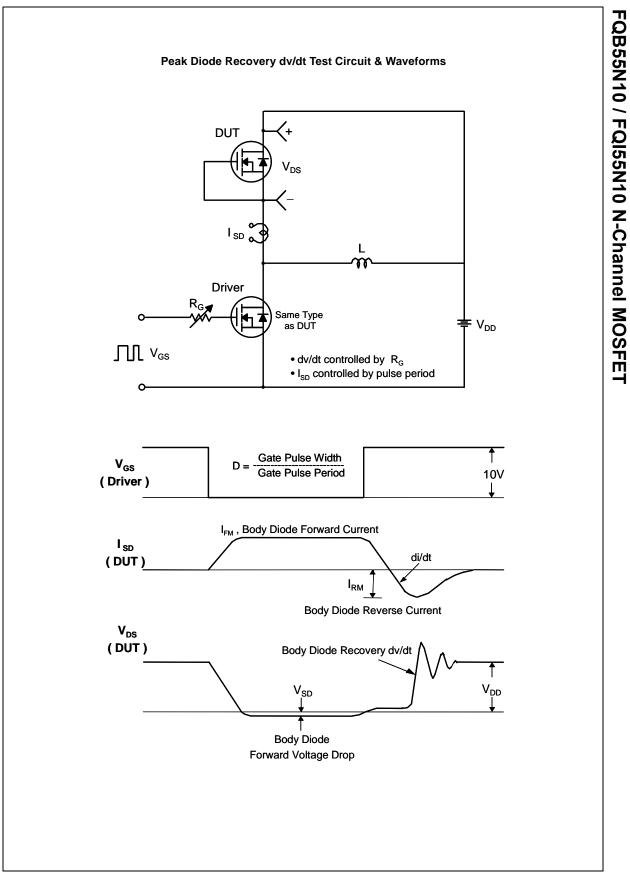
BV <sub>DSS</sub>		Test Conditions		Min	Тур	Max	Unit
	racteristics						
ABV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		100			V
	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu$ A, Referenced to 25°C			0.1		V/°C
DSS	Zara Cata Valtaga Drain Current	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V				1	μA
	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 80 V, T <sub>C</sub> = 150°C				10	μA
GSSF	Gate-Body Leakage Current, Forward	$V_{GS} = 25 \text{ V}, V_{DS} = 0 \text{ V}$				100	nA
GSSR	Gate-Body Leakage Current, Reverse	$V_{GS}$ = -25 V, $V_{DS}$ = 0 V				-100	nA
On Char	acteristics						
	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		2.0		4.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 27.5 \text{ A}$			0.021	0.026	Ω
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 40 V, I <sub>D</sub> = 27.5 A	(Note 4)		38		S
I							
-	c Characteristics						
	Input Capacitance	$V_{DS} = 25 V, V_{GS} = 0 V,$			2100	2730	pF
	Output Capacitance	f = 1.0 MHz			640	830	pF
C <sub>rss</sub>	Reverse Transfer Capacitance				130	170	pF
Switchin	ng Characteristics						
1	Turn-On Delay Time				25	60	ns
-()	Turn-On Rise Time	$V_{DD} = 50 \text{ V}, \text{ I}_{D} = 55 \text{ A},$			250	510	ns
	Turn-Off Delay Time	R <sub>G</sub> = 25 Ω			110	230	ns
	Turn-Off Fall Time	(	Note 4, 5)		140	290	ns
	Total Gate Charge	V <sub>DS</sub> = 80 V, I <sub>D</sub> = 55 A,			75	98	nC
	Gate-Source Charge	$V_{GS} = 10 V$			13		nC
-	Gate-Drain Charge		Note 4, 5)		36		nC
					I		
	ource Diode Characteristics an	•					
0	Maximum Continuous Drain-Source Dic					55	A
	Maximum Pulsed Drain-Source Diode F					220	A
-	Drain-Source Diode Forward Voltage	$V_{GS} = 0 V, I_S = 55 A$				1.5	V
-	Reverse Recovery Time	$V_{GS} = 0 V, I_S = 55 A,$ $dI_F / dt = 100 A/\mu s$	(Note 4)		100		ns
	Reverse Recovery Charge	$dF / dt = 100 A/\mu s$	(		380		nC

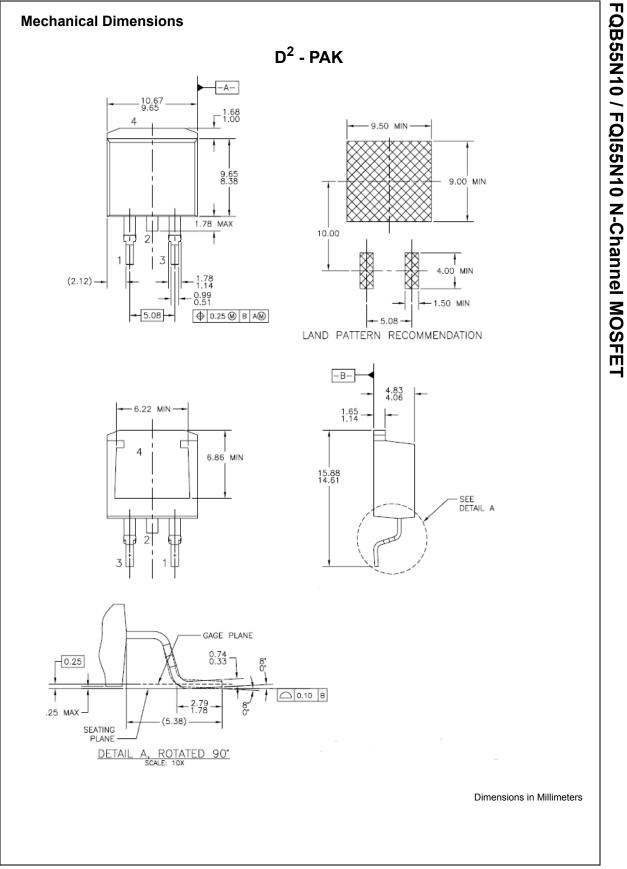




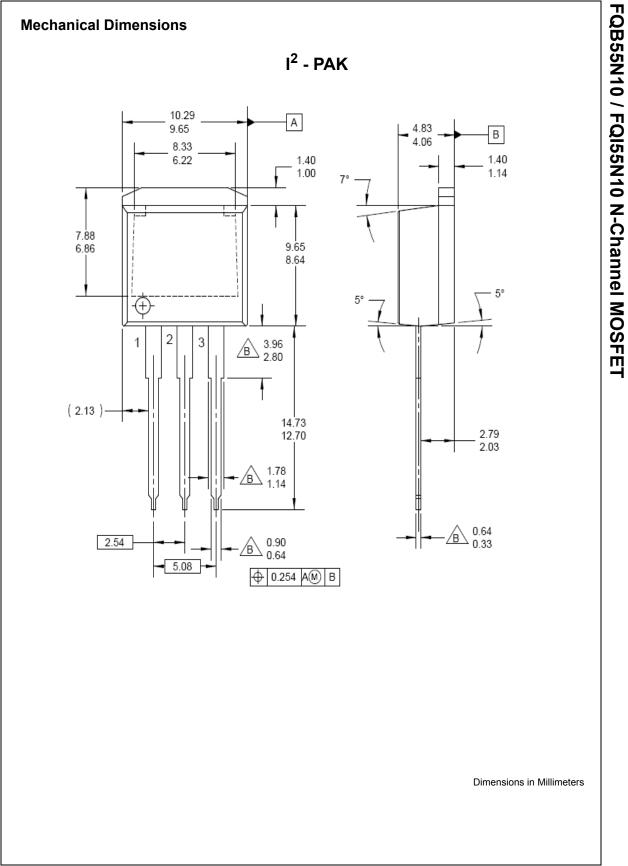


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